# Physics and phase transitions in parallel computational complexity

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#### Collaborators

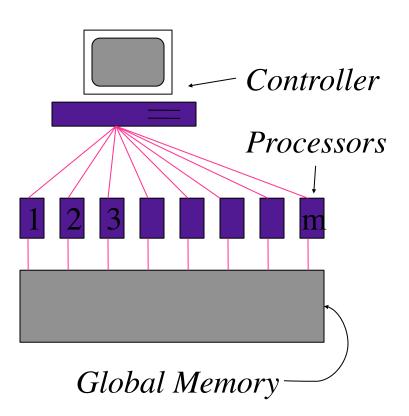
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# Outline

- Parallel computing and computational complexity
- Parallel complexity of models in statistical physical
- Random circuit value problem: complexity of solving and sampling

# Parallel Random Access Machine

PRAM



•Each processor runs the same program but has a distinct label

•Each processor communicates with any memory cell in a single time step.

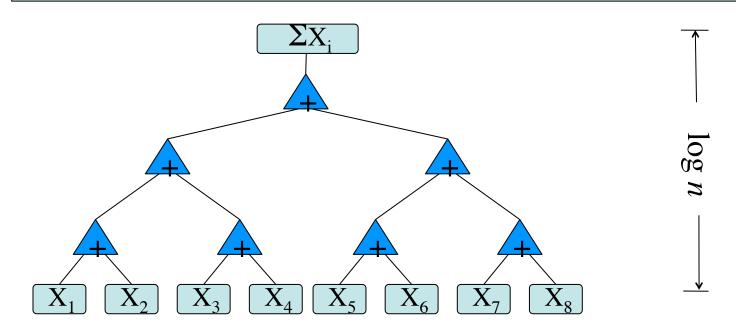
•Primary resources:

Parallel time

•Number of processors

# **Parallel Computing**

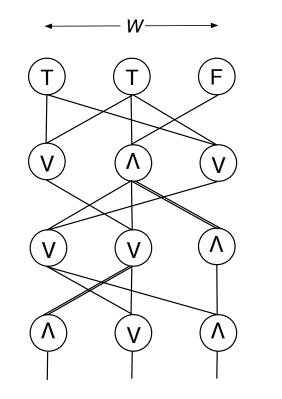
Adding *n* numbers can be carried out in  $O(\log n)$  steps using O(n) processors.



Connected components of a graph can be found in  $O(\log^2 n)$  steps using  $n^2$  processors.

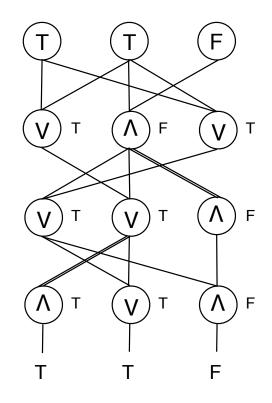
# Complexity Classes and P-completeness

- •**P** is the class of *feasible* problems: solvable with polynomial work.
- •NC is the class of problems efficiently solved in parallel (polylog time and polynomial work,  $NC \subseteq P$ ).
- •Are there feasible problems that cannot be solved efficiently in parallel ( $P \neq NC$ )?
- •**P**-complete problems are the hardest problems in **P** to solve in parallel. It is believed they are *inherently sequential:* not solvable in polylog time.
- •The Circuit Value Problem is **P**-complete.

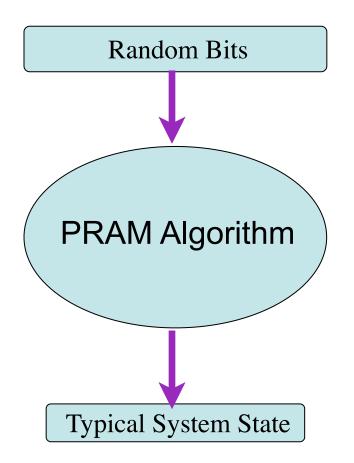


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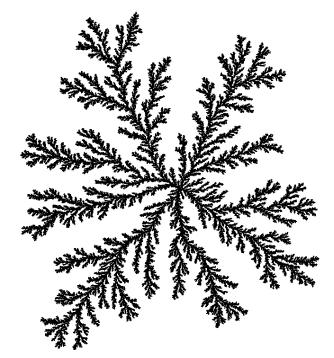
# **Sampling Complexity**



•Models and algorithms in statistical physics convert random bits into typical system states.

# **Diffusion Limited Aggregation**

Witten and Sander, PRL 47, 1400 (1981)

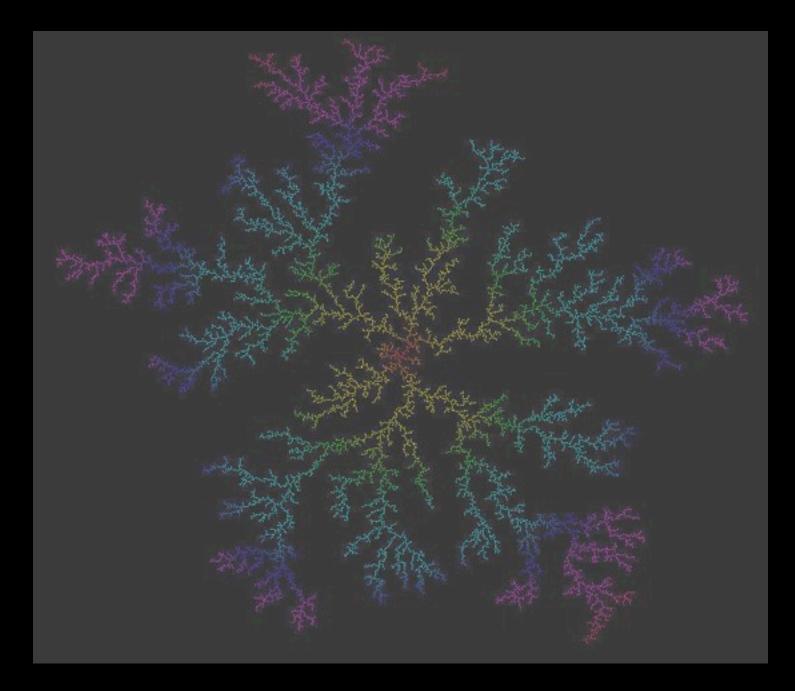


•Particles added *one at a time* with sticking probabilities given by the solution of Laplace's equation.

- •Self-organized fractal object  $d_f=1.715...$  (2D)
- Physical systems:
   Fluid flow in porous media
   Electrodeposition
   Bacterial colonies

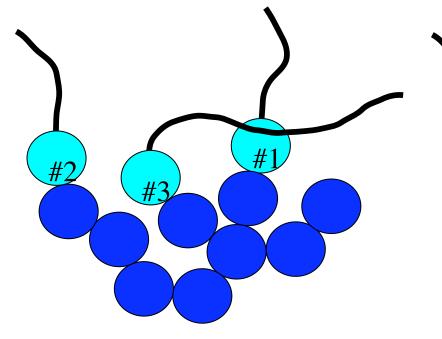
#### Random Walk Dynamics for DLA

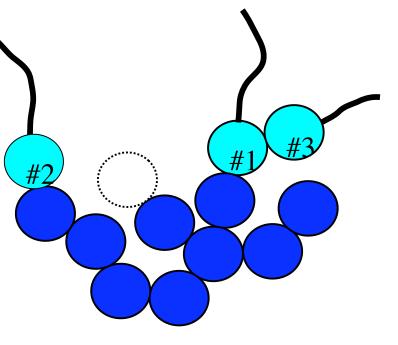
Tuesday, September 1, 2009



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#### The Problem with Parallelizing DLA





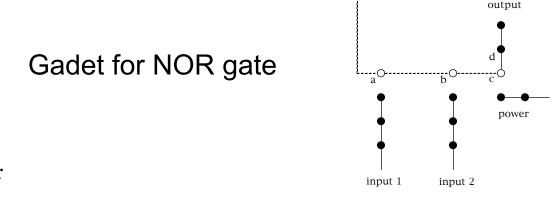
Parallel dynamics ignores *interference* between 1 and 3

Sequential dynamics

# Complexity of DLA

*Theorem*: Determining the shape of an aggregate from the random walks of the constituent particles is a **P**-hard problem.

Proof idea: Reduce the Circuit Value Problem to DLA dynamics.

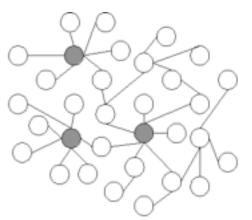


Caveats:

- 1.  $P \neq NC$  not proven
- 2. Average case may be easier than worst case
- 3. Alternative dynamics may be faster than random walk dynamics for sampling DLA

# Sequential models with polylog parallel complexity

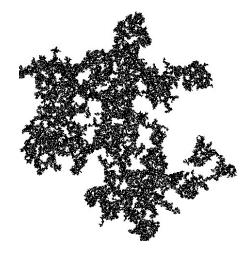
- •Eden growth
- Invasion percolation
- Scale free networks
- Ballistic deposition
- •Bak-Sneppen model
- Internal DLA



Scale free network



Eden growth



Invasion percolation

#### **Internal DLA**

Particles start at the origin, random walk and stick where they first leaves the cluster.

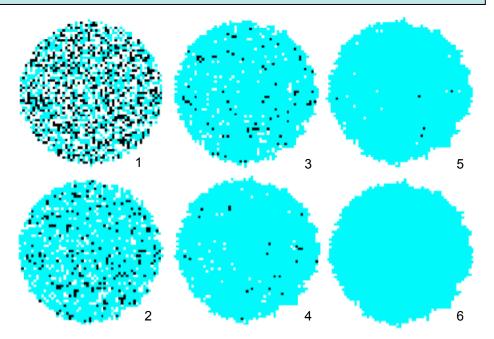


Shape approaches a circle with logarithmic fluctuations.
P-completeness proof fails. (However, IDLA is CC-complete)

# Parallel Algorithm for IDLA

C. Moore and JM, J. Stat. Phys. 99, 661 (2000)

- 1. Start with seed particle at the origin and N walk trajectories
- 2. Place particles at expected positions along their trajectories.
- 3. Iteratively move particles until holes and multiple occupancies are eliminated

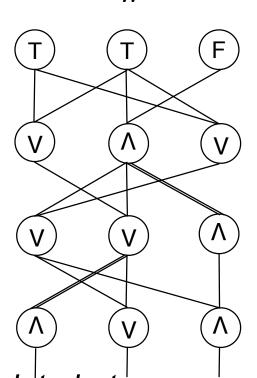


Cluster of 2500 particles made in 6 parallel steps.

Average parallel time polylogarthmic or possibly a small power in *N*.

# Random Monotone CVP

- •Circuit arranged in levels with *W* gates on a level and *D* levels.
- $\tau_0$  =fraction of TRUE inputs.
- p =fraction of OR gates.
- •Gates at level *n*+1 randomly take *k* inputs from gates at level *n* (with replacement).



Monotone CVP is P-complete but how hard is it on average to evaluate the circuit in parallel?

# Recursion relations, k=2

• Let  $\tau_n$  be the expected fraction of gates evaluating to TRUE at level n.

$$\tau_{n+1} = p(1 - (1 - \tau_n)^2) + (1 - p)\tau_n^2$$

Absorbing fixed points at  $\tau=0~~{\rm and}~~\tau=1$  .

## Recursion relations, k=2

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$$\tau_{n+1} = p(1 - (1 - \tau_n)^2) + (1 - p)\tau_n^2$$

$$0 - \tau_n - 1 \quad p < 1/2 \quad \text{mainly AND}$$

$$0 - \tau_n - 1 \quad p > 1/2 \quad \text{mainly OR}$$

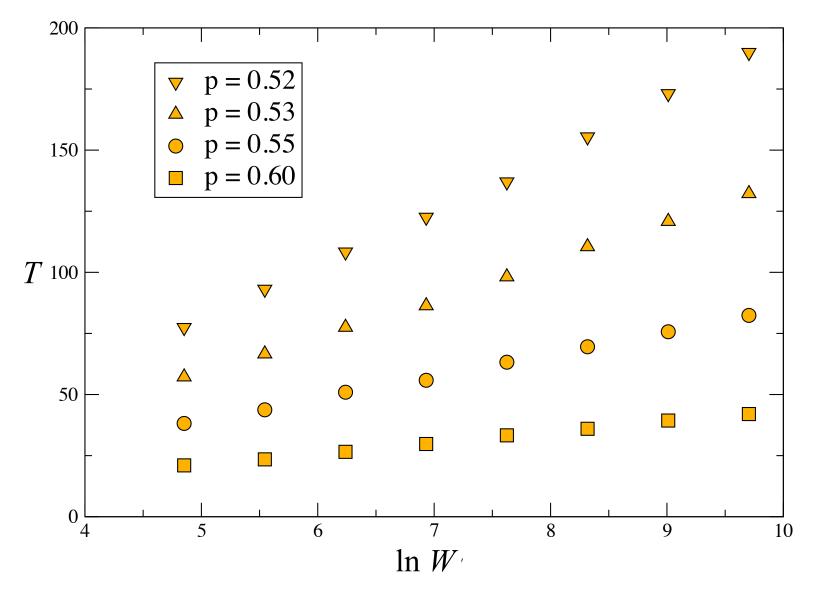
#### Linearize around fixed points

Near the  $\tau = 0$  fixed point for p < 1/2 the linearized recursion relations are:

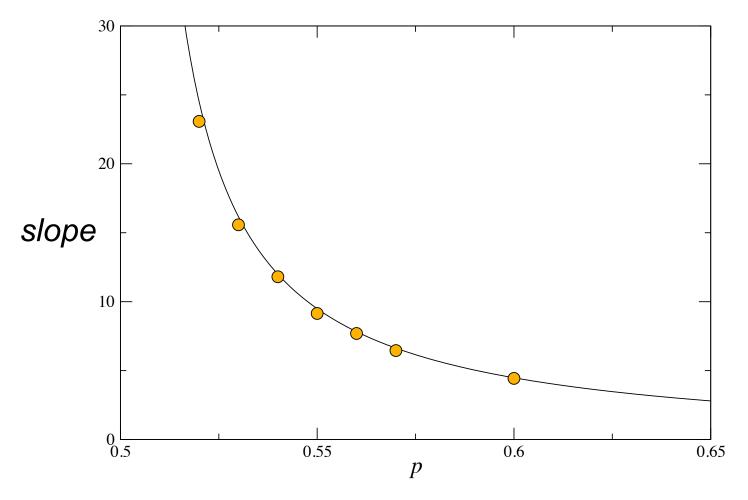
$$\tau_{n+1} = 2p\tau_n + \mathcal{O}(\tau_n^2)$$

Let T be the time to saturation to all FALSE,

$$\tau_T \approx 1/W$$
$$T \sim \frac{\ln W}{-\ln(2p)}$$



Time to saturation T as a function of circuit width W for various fractions p of OR gates.



Slope of the logarithmic scaling of the saturation time vs. p. The solid line is the prediction,  $-1/\ln(2(1-p))$ .

# Critical point at p=1/2

The number of gates,  $X_n$  evaluating to TRUE at level n obeys a stochastic recursion relation,

$$X_{n+1} = \mathcal{B}(W, X_n/W)$$

Here  $\mathcal{B}(n,p)$  is a binomial random variable.

After taking the continuum limit, one obtains a diffusion process with absorbing endpoints and a diffusion coefficient that vanishes at the endpoints.

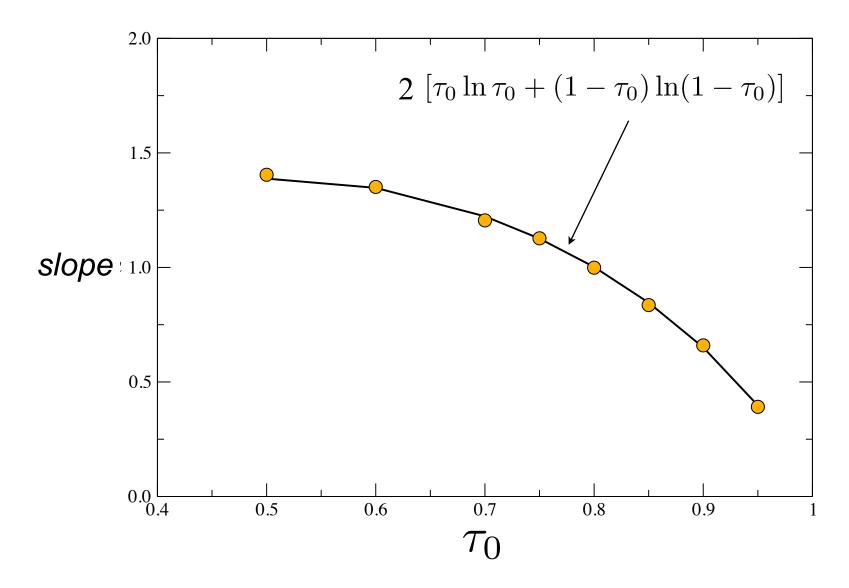
#### **Critical Saturation Time**

Using known results for mean first passage times with the spatially non-uniform diffusion coefficient

$$D(x) = \frac{x}{2}\left(1 - \frac{x}{W}\right)$$

we obtain a linear saturation time:

 $T = -2W \left[\tau_0 \ln \tau_0 + (1 - \tau_0) \ln(1 - \tau_0)\right]$ 



Slope of the linear scaling of the saturation time vs. *W*.

#### Summary for two input gates

• For  $p \neq 1/2$ 

Circuit evaluation easy

• For p = 1/2

 $T \sim W$ 

 $T \sim \ln W$ 

Circuit evaluation hard

k > 2

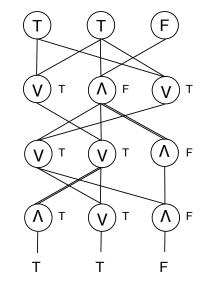
- For p<1/k or p>1-1/k have T ~ ln W →
   Fast circuit evaluation.
- For 1/k have non-trivial fixed point:

$$0 < \tau^* < 1$$

Circuit does not saturate to a single value except via a large deviation  $\rightarrow$  *Slow circuit evaluation*.

#### **Generating Circuit+Solution Pairs**

 Q: How difficult is it to simultaneously generate an instance of random monotone CVP together with its evaluation?



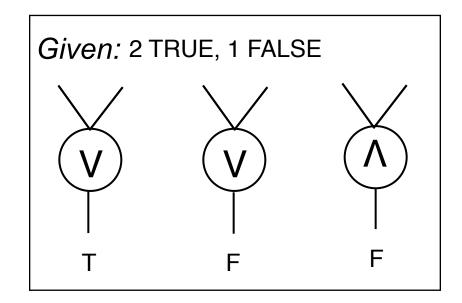
• A: For any values of the parameters, a random instance chosen from the correct distribution *and* its evaluation can be generated in polylog parallel time on a PRAM.

#### Fast Parallel Sampling of Circuit +Evaluation Pairs

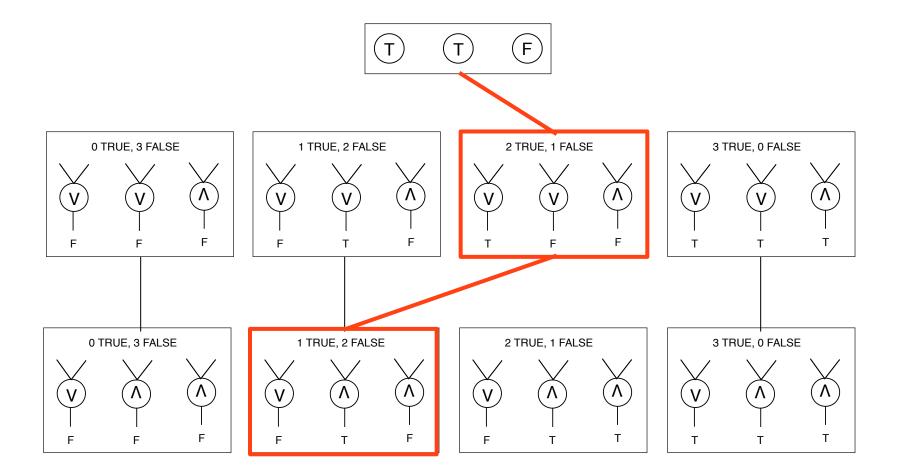
- Idea: In parallel generate an instance of each level-gates and their inputs and outputs--then put the levels together into a complete circuit+evaluation.
- Difficulty: Inputs to layer *n*+1 are not known until layer *n* is evaluated.

 Solution: The <u>number</u> of TRUE inputs is all that is required to generate a random level. In parallel construct *W*+1 instances of each level, one for each number of TRUE inputs.

#### **Construct one level**

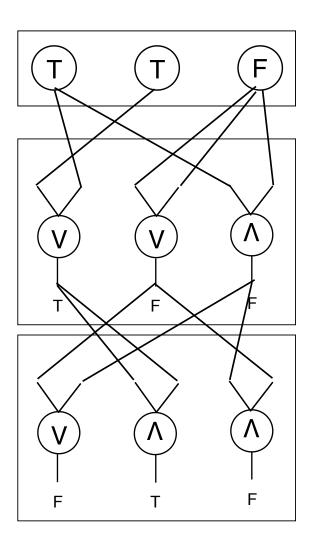


#### Attaching levels into a circuit+evaluation



Tuesday, September 1, 2009

#### Wiring the circuit



#### Conclusion

- Parallel computational complexity provides a unique perspective on models in statistical physics.
- Simple methods yield interesting results for random ensembles of CVP revealing phase transitions in complexity.
- Although CVP is hard to solve in parallel, it is easy to generate random instances and solutions simultaneously.